

Mitigating Arc Inception via Transformational Array Instrumentation

Meghan Bush, NASA GRC, Photovoltaics and Electrochemical Systems Branch NAC Technology, Innovation, and Engineering Meeting September 5, 2024







- Overview of MAI TAI
- Introduction to Spacecraft Charging and Arcing
- Active Mitigation concept
- Active mitigation enables new tech
- ECI Experiences & Lessons Learned

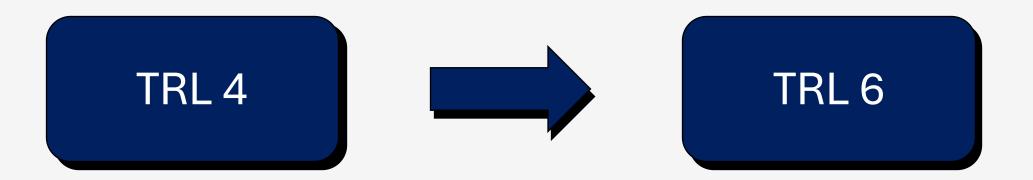
Goal: enable **resilient**, **high voltage**, **high power density** solar arrays



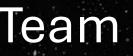




- FY24 Early Career Initiative (ECI) Award
- Funded by NASA's Space Technology Mission Directorate (STMD)
- 2-year, \$2.5 million effort
- Research and Development







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Early Career

- Meghan Bush Principal Investigator
- Jeremiah Sims Co-Investigator
- Dr. Kristina Vailonis Thin Films
- **Brooke Weborg** Data Analysis, Machine Learning
- **Darcy DeAngelis** Safety and Mission Assurance
- Natalie Weckesser Operations Research Analyst
- **Alexis Arroyo** Electrical Engineering Support
- Hana Winchester Data Science Summer Intern

Senior Staff & Mentors

- **Dr. Boris Vayner** Spacecraft Charging Expert
- Dr. Timothy J. Peshek Space Photovoltaics
- **Dr. Kristen John** Lunar Dust Impacts









B. Weborg

A. Arroyo





N. Weckesser















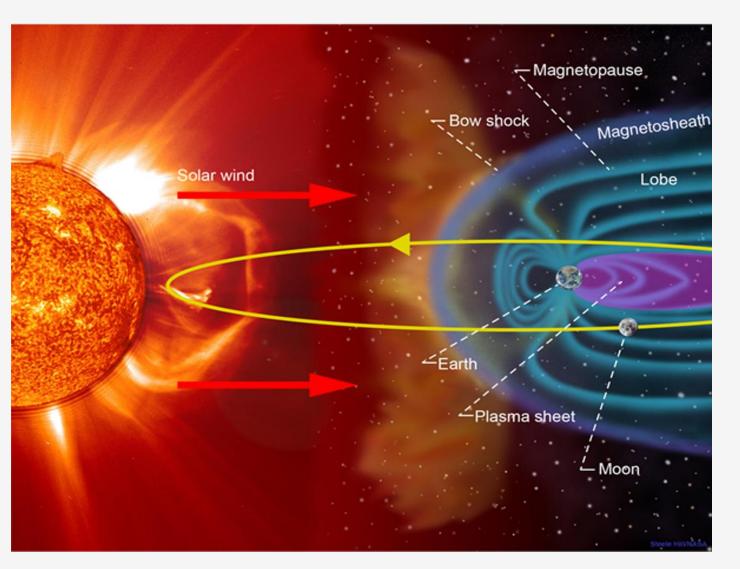




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Spacecraft Charging



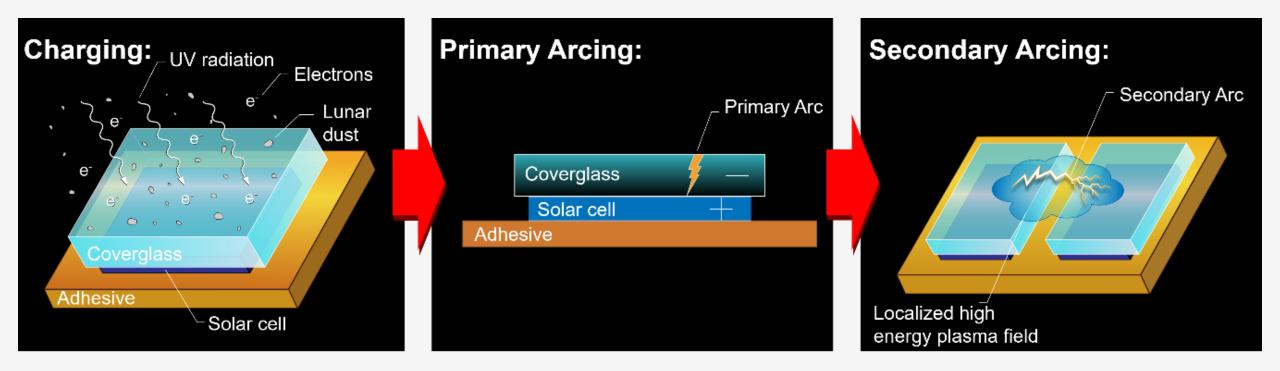
 Charging regimes on the lunar surface vary wildly throughout the lunar cycle

Passive mitigation techniques
design for worst-case scenario



Spacecraft Charging

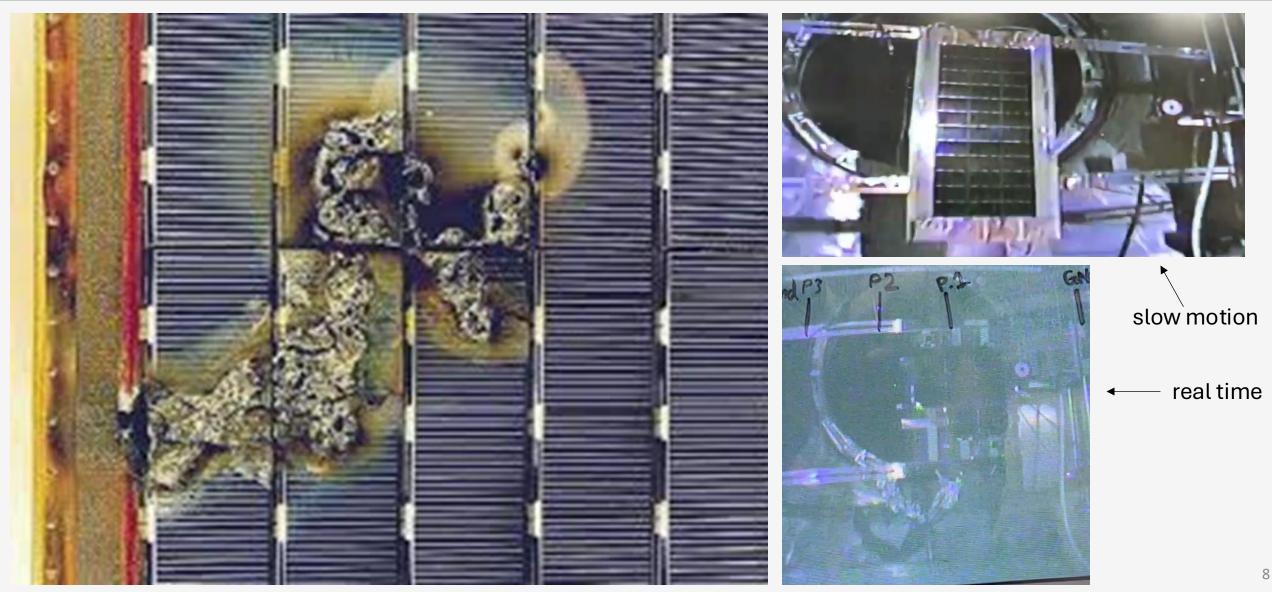






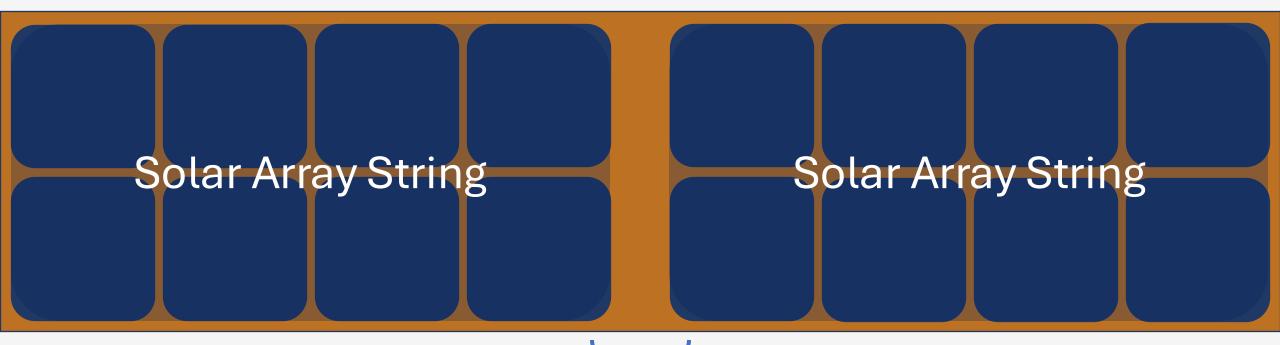
Secondary Arcing







Current State of Practice



Distance between strings: **above a cell-dependent threshold** Cell-to-cell voltage: < **40V**

Does not account for *next-generation* solar cells (larger/higher voltage, thin film) and *lunar* environment

Capabilities under Development

Passive:

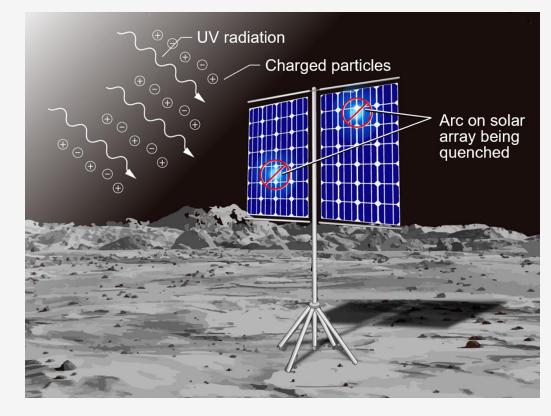
- Aimed at thin film solar cells (susceptible to primary arcing)
- Develop and test architecture to prevent primary arcs

Active:

- Improve upon secondary arcing protections
- Novel high-speed circuitry that detects and quenches secondary arcs

Adaptive:

- Protect solar arrays in variable charging environments while maximizing power
- Develop dataset and ML/AI algorithm for controlling circuitry in lunar environmental extremes





NASA







- High Voltage Operations: bypassing current best practices allows for higher bus voltages, lowering conductor mass and increasing power output
- Enable next-generation solar cells: prepare novel solar cells to survive the harsh lunar surface charging environment
- **Boost reliability and resiliency of solar arrays**: lower risk of arcing damage **increases array lifetimes**

STMD Shortfall 21596: *High Power Energy Generation on Moon and Mars Surfaces*



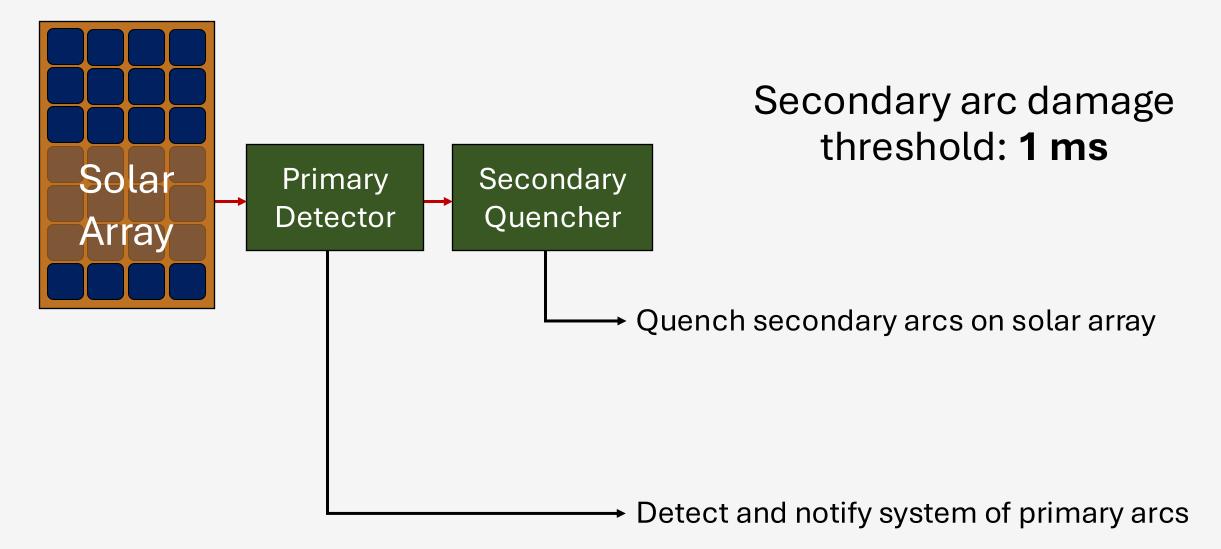




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Active Arc Mitigation



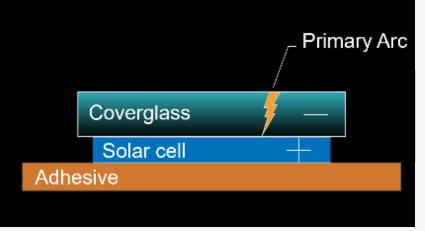


Primary Arc Detector



- Monitors the solar array current without interfering or impacting power
- Detects a primary arc event and notifies the system
- Key qualities: fast, accurate
- Crucial for ML/AI integration and variable environment sensing





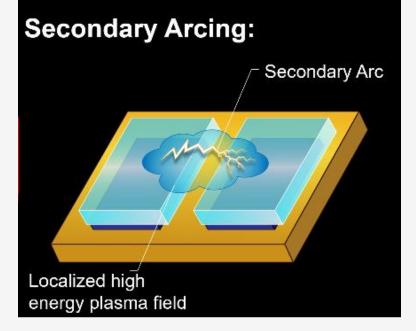




Secondary Arc Quencher



- Reroutes and absorbs the current generated during a secondary arc
- Key qualities: fast, robust
- Crucial for mitigating damage via secondary arcs







Secondary Arc Quencher



- Solar array voltage is shorted to 0 V
- Performance:
 - Average response time: 4.6 µs
 - Typical quench time: ~17 µs

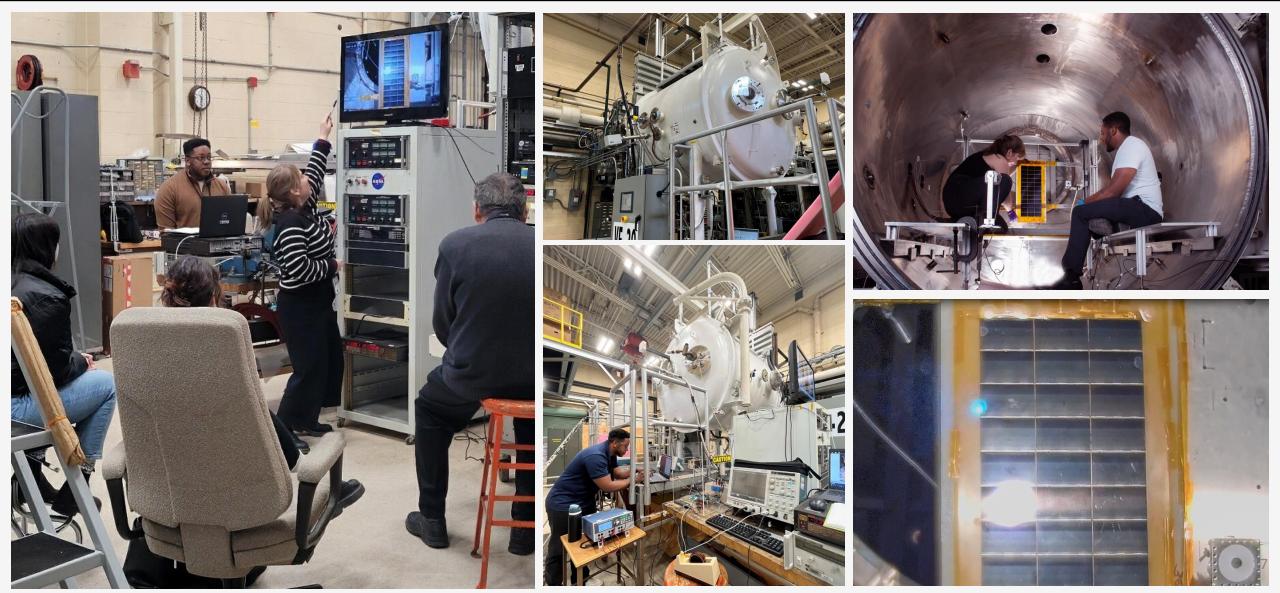


Temporary Sustained Arc Mitigation



Testing in the PIF



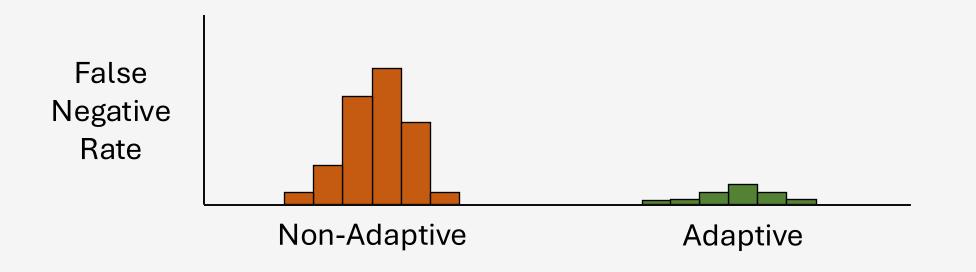




Adaptive Mitigation



- Rely on the **primary arc detection circuitry**; use arc rate to determine the environmental hazard level
- Exploring incorporating different environmental sensor to help inform design
- Acquire large dataset via ground testing in the PIF to train ML models
- Target: solar array operations as a function of local charging environment to maximize power output throughout the lunar cycle









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Next Generation Solar Cells



- Significantly less mass, higher power density than SOA solar cells
- Cheaper fabrication costs
- Compatible with ISRU efforts
- Must estimate time scale for damage
 - Cannot withstand heat of primary arcing events
 - Understand damage mechanisms to inform protective architecture designs



External Partners





- Leaders in terrestrial solar cell R&D
- Developing perovskites for space PV
- Advanced solar cell and materials characterization and testing



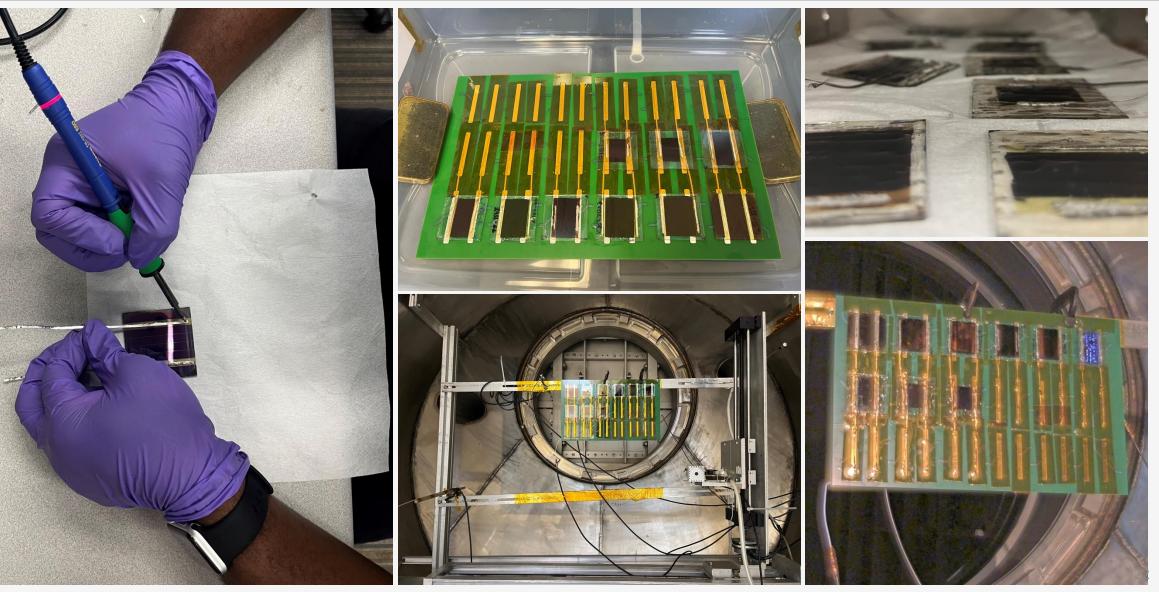
- State-of-the-art silicon solar cell fabrication and characterization facilities
- Advanced defect characterization



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Progress – Perovskite Testing

NASA









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ECI Program: highly unique opportunity to provide early career researchers autonomy and support in pursuing next-level technology development

Programmatic:

- Tailoring flight-like Safety and Mission Assurance (SMA) documentation for an R&D effort, in pursuit of eventual flight demonstration
- Takes more time to initiate and run a contract than expected

Technical

- Improving test flow and data collection in the Plasma Interaction Facility
- Advanced circuitry development and testing



Forward Work



- Investigate arcing behavior in **charged dust environment**
- Further development and testing of thin film solar cells
- Further validation of the active arc mitigation circuitry
- Machine learning algorithm development and testing







MAI TAI aims to enable **resilient**, **high voltage**, **high power density** solar array installations on the lunar surface through novel arcing mitigation technology development.



Backup Slides



Safety and Mission Assurance



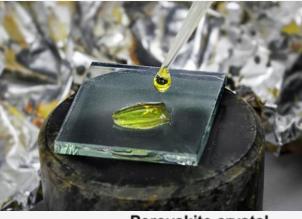
- The MAI TAI SMAP will guide all S&MA activities during development, build, and test of MAI TAI hardware and software (System Safety, Reliability, Quality Assurance, Risk Management)
- MAI TAI is a research project with an eventual goal to fly as a payload
 - Developed using NPR 7120.8 with input from NPR 7120.5
 - Allows for easier transition between program phases and reduces required future edits.
 - Few S&MA deliverables required for the research development phase, so SMAP has been tailored to create a framework for flight-required deliverables
- MAI TAI is pioneering an **agile-management structure** that will eliminate the need for major design reviews during the program.
 - S&MA milestones traditionally tied to design reviews (ex. Phase I Safety Review coincides with Preliminary Design Review).
 - Safety reviews instead align with **key technical milestones** at the PI's discretion.
- The SMAP will be reviewed and concurred by the Safety and Engineering Review Board for implementation on August 26, 2024.



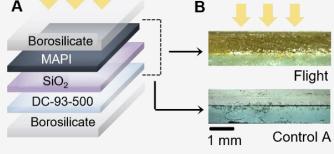


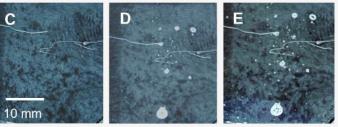


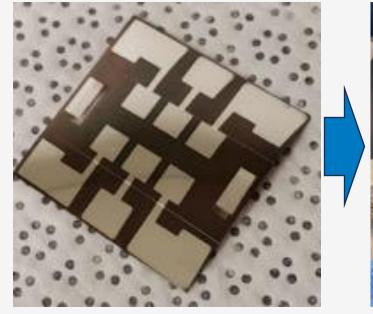


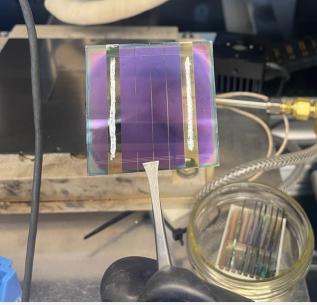


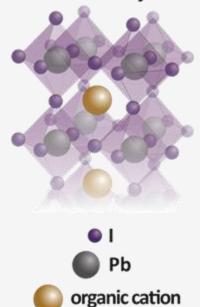
Perovskite crystal

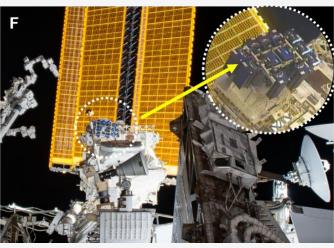












Delmas et al. Adv Ener. Mat. 2023

all images c/o NREL



Passive Mitigation



Transparent Conductive Oxides (TCOs) dissipate built-up charge on the surface of solar cells *without* significant absorption of incoming light.

Characterization Plan: Analyze thin film coatings before and after exposure experiments to understand their performance in extreme environments.



PVD interior

Physical Vapor Deposition (PVD) System



Thin Film Characterization



Techniques:

- Spectrophotometry: Optical properties (transmittance & reflectance)
- Fourier Transformed Infrared (FTIR)-Microscopy: allows for the visualization of the chemical composition of a sample
- Hall Effect Measurement: carrier mobility & conductivity
- X-ray Diffraction (XRD): bulk and thin film chemical analysis
- Scanning Electron Microscopy (SEM) w/ Energy Dispersive Spectroscopy (EDS): microscopy with elemental analysis
- X-ray Photoelectron Spectroscopy (XPS): material surface characterization- depth profile with elemental composition analysis
- Electron Beam Induced Current (EBIC) in SEM: visualization of electrically active areas on a sample and *characterization of defect sites*